

Automotive MOSFET

OptiMOS™ 7 Power-Transistor







Features

- OptiMOS[™] power MOSFET for automotive applications
- N-channel Enhancement mode Normal Level
- Extended qualification beyond AEC-Q101
- Enhanced electrical testing
- Robust design
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- RoHS compliant
- 100% Avalanche tested



General automotive applications.



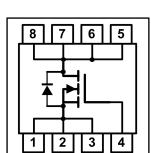
Qualified for automotive applications. Product validation according to AEC-Q101.

Product Summary

V_{DS}	40	V
R _{DS(on)}	2.00	mΩ
I _D (chip limited)	150	Α

Туре	Package	Marking
IAUZN04S7N020	PG-TSDSON-8-44	4B





IAUZN04S7N020



Table of Contents

Description	1
Maximum ratings	3
Thermal characteristics	4
Electrical characteristics	4
Electrical characteristics diagrams	6
Package outline & footprint	10
Revision history	11
Disclaimer	12

IAUZN04S7N020



Maximum Ratings

at $T_j = 25$ °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	$V_{\rm GS} = 10 \text{V}$, Chip limitation ^{1,2)}	150	А
		V _{GS} = 10 V, DC current	60	
		$T_a = 100$ °C, $V_{GS} = 10$ V, R_{thJA} on $2s2p^{2,3)}$	23	
Pulsed drain current ²⁾	$I_{\rm D,pulse}$	$T_{\rm C} = 25^{\circ}{\rm C}, t_{\rm p} = 100 \mu{\rm s}$	400	1
Avalanche energy, single pulse ²⁾	E_{AS}	I _D = 30 A	93	mJ
Avalanche current, single pulse	I _{AS}	-	60	А
Gate source voltage	V_{GS}	-	±20	V
Power dissipation	P _{tot}	T _C = 25°C	83	W
Operating and storage temperature	$T_{\rm j}, T_{\rm stg}$	-	-55 +1 75	°C

IAUZN04S7N020



Thermal Characteristics²⁾

Davamatav	Symbol	Conditions	Values			I I mit
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	_	_	1.8	K/W
Thermal resistance, junction - ambient ³⁾	R_{thJA}	-	-	40	-	

Electrical Characteristics

at T_i=25 °C, unless otherwise specified

Parameter	Sumb al	Sumbal Canditions	Values				
	Symbol	Conditions	min.	typ.	max.	Unit	
Static Characteristics							
Drain-source breakdown voltage	V _{(Br)DSS}	$V_{GS} = 0 \text{ V},$ $I_D = 1 \text{ mA}$	40	-	-	V	
Gate threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 30 \mu A$	2.2	2.6	3.0		
		$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25^{\circ}\text{C}$	-	-	1	μА	
Zero gate voltage drain current	7 _{DSS}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V},$ $T_j = 100^{\circ}\text{C}^{2j}$	_	_	7		
Gate-source leakage current	I _{GSS}	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	100	nA	
		$V_{GS} = 7 \text{ V}, I_D = 15 \text{ A}$	_	2.14	2.49	mΩ	
Drain-source on-state resistance	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$	-	1.76	2.00]	
Gate resistance ²⁾	R _G	-	-	1.3	-	Ω	

IAUZN04S7N020



Parameter	Cumbal	Symbol Conditions	Values			l lmia	
	Symbol		min.	typ.	max.	Unit	
Dynamic Characteristics ²⁾							
Input capacitance	Ciss		_	2003	2604	pF	
Output capacitance	C oss	$V_{GS} = 0 \text{ V}, V_{DS} = 20 \text{ V}, f = 1 \text{ MHz}$	_	1166	1516		
Reverse transfer capacitance	C rss		_	41	62		
Turn-on delay time	t _{d(on)}		_	6	-	ns	
Rise time	t _r	$V_{DD} = 20 \text{ V}, V_{GS} = 10 \text{ V},$ $I_{D} = 30 \text{ A}, R_{G} = 3.5 \Omega$	_	6	-		
Turn-off delay time	t _{d(off)}		_	14	-		
Fall time	t _f		_	10	-		

Gate Charge Characteristics2)

Gate to source charge	Q _{gs}		ı	8.2	11	nC
Gate to drain charge	Q _{gd}	$V_{DD} = 20 \text{ V}, I_D = 30 \text{ A},$	-	5.9	9	
Gate charge total	Qg	$V_{DD} = 20 \text{ V}, I_D = 30 \text{ A},$ $V_{GS} = 0 \text{ to } 10 \text{ V}$	-	29	38	
Gate plateau voltage	V _{plateau}		-	4.1	-	V

Reverse Diode

Diode continuous forward current ²⁾	Is	T _C = 25°C	ı	ı	60	А
Diode pulse current ²⁾	I _{S,pulse}	$T_{\rm C} = 25^{\circ}{\rm C}, t_{\rm p} = 100 \mu{\rm s}$	ı	ı	400	
Diode forward voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_F = 30 \text{ A}, T_j = 25^{\circ}\text{C}$	ı	0.8	0.95	V
Reverse recovery time ²⁾	t _{rr}	$V_R = 20 \text{ V}, I_F = 50 \text{ A}$	-	26	39	ns
Reverse recovery charge ²⁾	Q _{rr}	$di_F/dt = 100 A/\mu s$	ı	10	20	nC

 $^{^{1)}}$ Practically the current is limited by the overall system design including the customer-specific PCB.

²⁾ The parameter is not subject to production testing – specified by design.

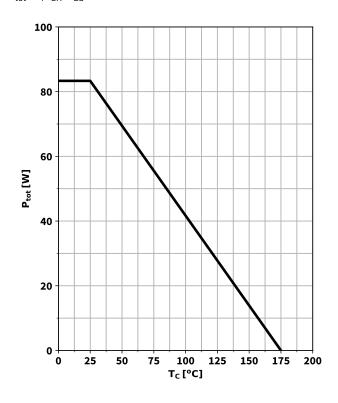
 $^{^{3)}}$ Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7). PCB is vertical in still air.



Electrical characteristics diagrams

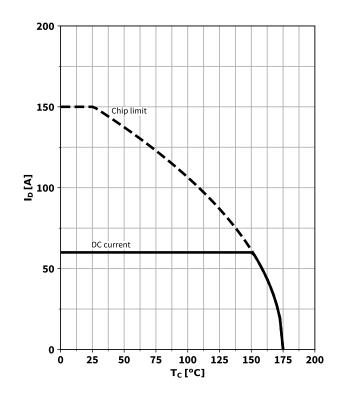
1 Power dissipation

 $P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$



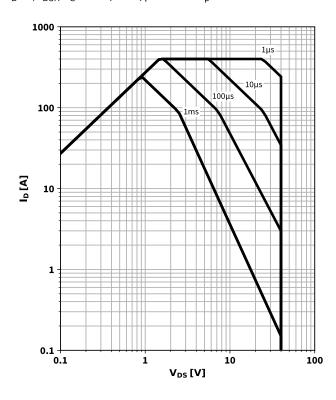
2 Drain current

 $I_{\text{D}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$



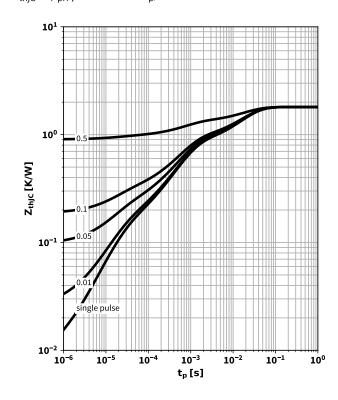
3 Safe operating area

 $I_{\rm D}$ = f($V_{\rm DS}$); $T_{\rm C}$ = 25 °C; D = 0; parameter: $t_{\rm p}$



4 Max. transient thermal impedance

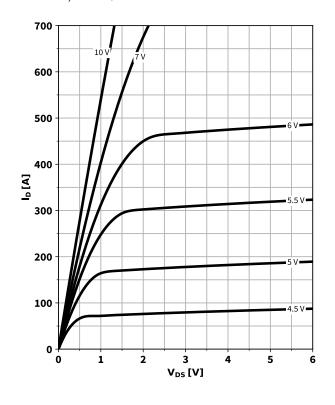
 $Z_{\text{thJC}} = f(t_p)$; parameter: D = t_p/T





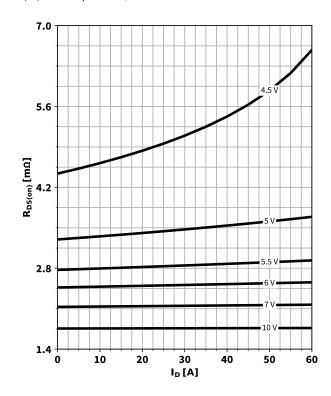
5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \,^{\circ}\text{C}; \text{ parameter: } V_{GS}$



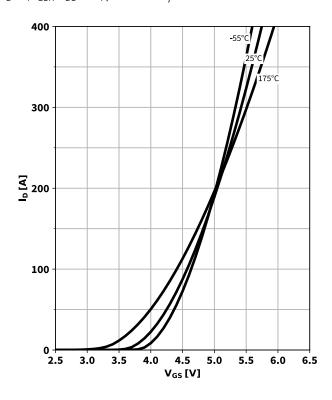
6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \,^{\circ}C; parameter: V_{GS}$



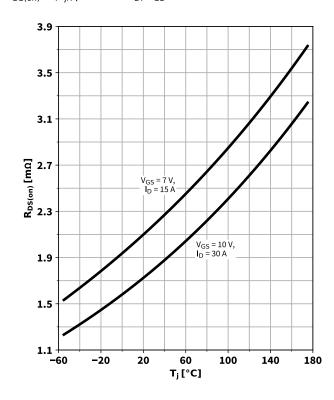
7 Typ. transfer characteristics

 $I_D = f(V_{GS}); V_{DS} = 6 \text{ V}; \text{ parameter: } T_j$



8 Typ. drain-source on-state resistance

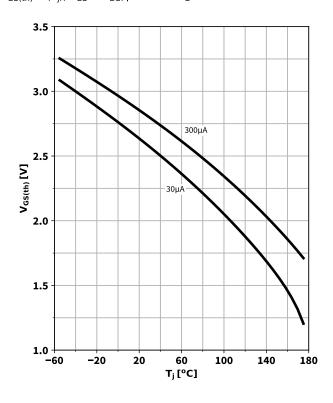
 $R_{DS(on)} = f(T_j)$; parameter: I_D , V_{GS}





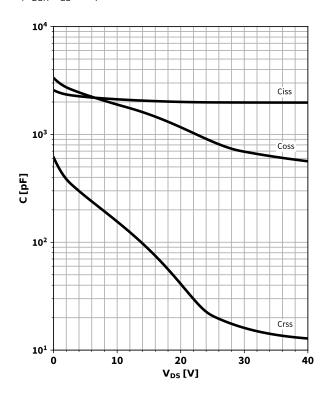
9 Typ. gate threshold voltage

 $V_{\text{GS(th)}} = f(T_{\text{j}}); V_{\text{GS}} = V_{\text{DS}}; \text{ parameter: } I_{\text{D}}$



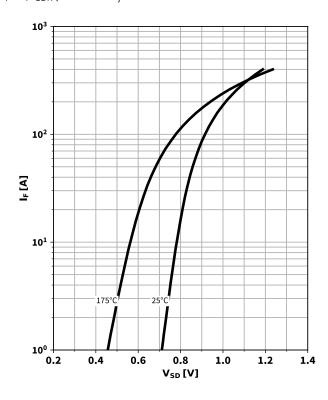
10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$



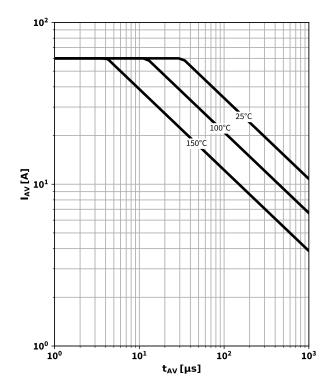
11 Typ. forward diode characteristics

 $I_F = f(V_{SD})$; parameter: T_j



12 Typ. avalanche characteristics

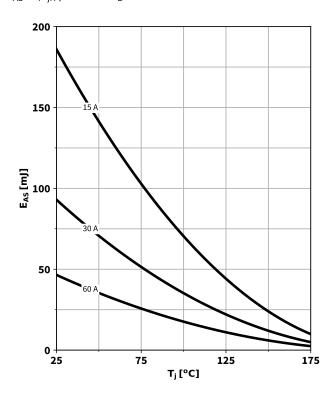
 $I_{AS} = f(t_{AV})$; parameter: $T_{j(start)}$





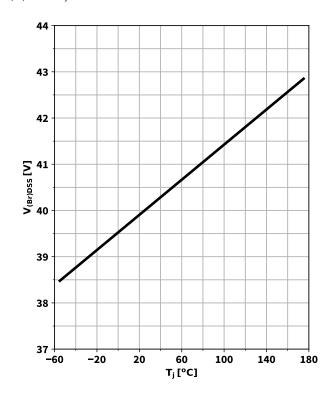
13 Typical avalanche energy

 $E_{AS} = f(T_j)$; parameter: I_D



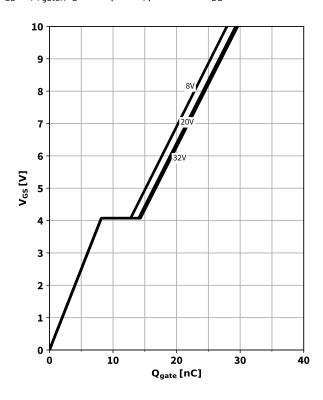
14 Drain-source breakdown voltage

 $V_{(Br)DSS} = f(T_j); I_D = 1 \text{ mA}$

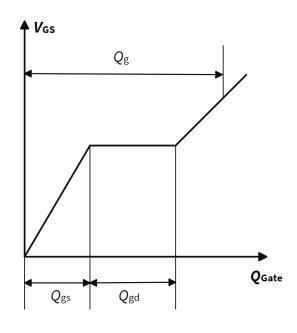


15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 30 \text{ A pulsed}; parameter: } V_{DD}$



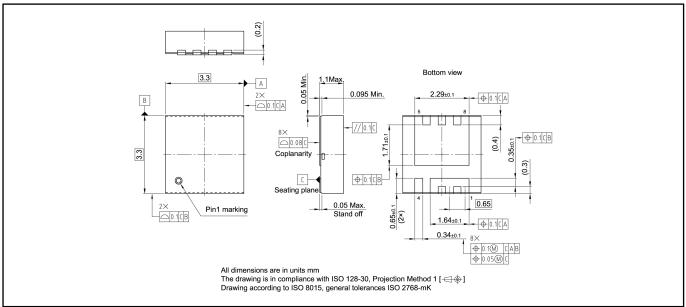
16 Gate charge waveforms



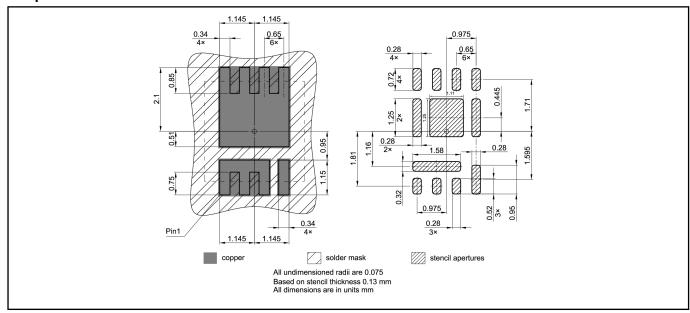
IAUZN04S7N020



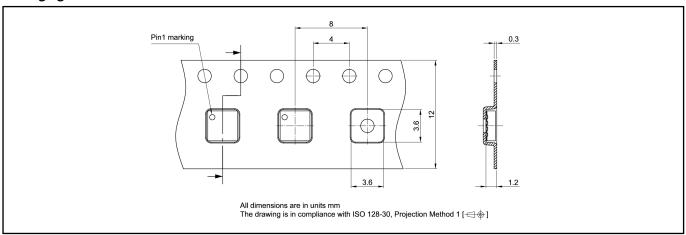
Package Outline



Footprint



Packaging



IAUZN04S7N020



Revision History

Revision	Date	Changes
Revision 1.0	2024-09-18	Final Data Sheet

Trademarks

Edition 2024-09-18

Published by

Infineon Technologies AG

81726 Munich, Germany

© 2024 Infineon Technologies AG

All Rights Reserved.

Do you have any questions about any aspect of this document?

Email: erratum@infineon.com

Document reference IAUZN04S7N020-Data-Sheet-10-Infineon

IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications. The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact the nearest Infineon Technologies Office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.